Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,174	OGAWA ET AL.	
Examiner	Art Unit	
Gina C Vu	1617	

	SEARCHED			
Class	Subclass	Date	Examiner	
424	404, 401	3/14/2006	GY	
514	715, 724	3/14/2006	GY	
514	730,738,	3/14/2006	GY	

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
404, 401	3/14/2006	GY		
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	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
West, Inventor, STN Parent: US 6620418 B1	3/14/2006	GY		